

Search Notes

Application/Control No.

10/539,861

Examiner

EDMUND H. LEE

Applicant(s)/Patent under
Reexamination

SCHUREN ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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